

SEMICONDUCTOR®

## **KSC5367F**

## High Voltage and High Reliability

- High speed Switching
- Wide Safe Operating Area
- High Collector-Base Voltage



1.Base 2.Collector 3.Emitter

# NPN Triple Diffused Planar Silicon Transistor

Absolute Maximum	<b>Ratings</b> $T_C=25^{\circ}C$ unless otherwise noted
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Symbol	Parameter	Value	Units
V <sub>CBO</sub>	Collector-Base Voltage	1600	V
V <sub>CEO</sub>	Collector-Emitter Voltage	800	V
V <sub>EBO</sub>	Emitter-Base Voltage	12	V
I <sub>C</sub>	Collector Current (DC)	3	А
I <sub>CP</sub>	*Collector Curren (Pulse)	6	А
I <sub>B</sub>	Base Current (DC)	2	А
I <sub>BP</sub>	*Base Current (Pulse)	4	А
P <sub>C</sub>	Power Dissipation(T <sub>C</sub> =25°C)	40	W
TJ	Junction Temperature	150	°C
T <sub>STG</sub>	Storage Temperature	- 65 ~ 150	°C

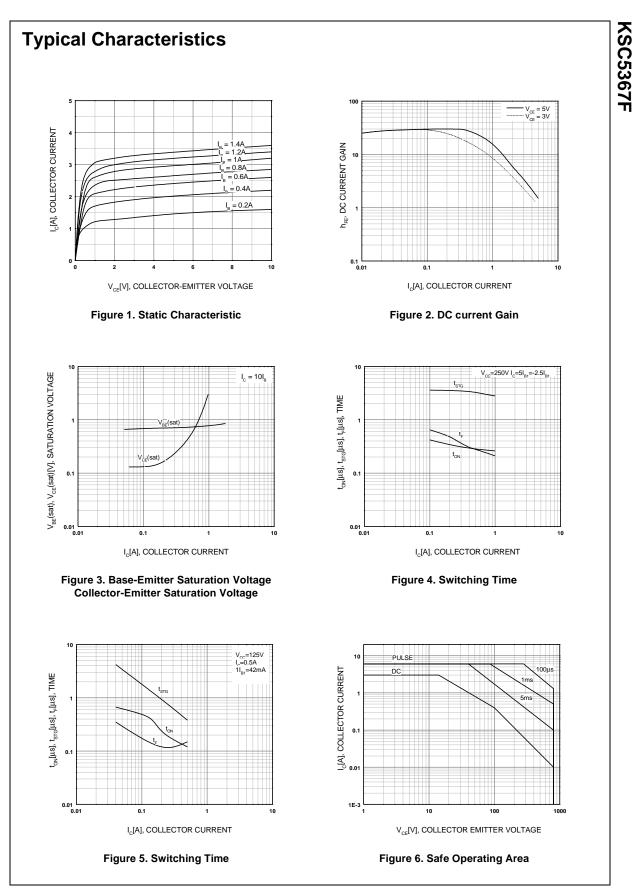
\* Pulse Test: Pulse Width=5ms, Duty Cycle≤10%

### Thermal Characteristics $T_C=25^{\circ}C$ unless otherwise noted

Symbol	Characteristics Ratin			Unit
R <sub>θjc</sub>	Thermal Resistance	Junction to Case	3.1	°C/W
$R_{ heta ja}$		Junction to Ambient	62.5	

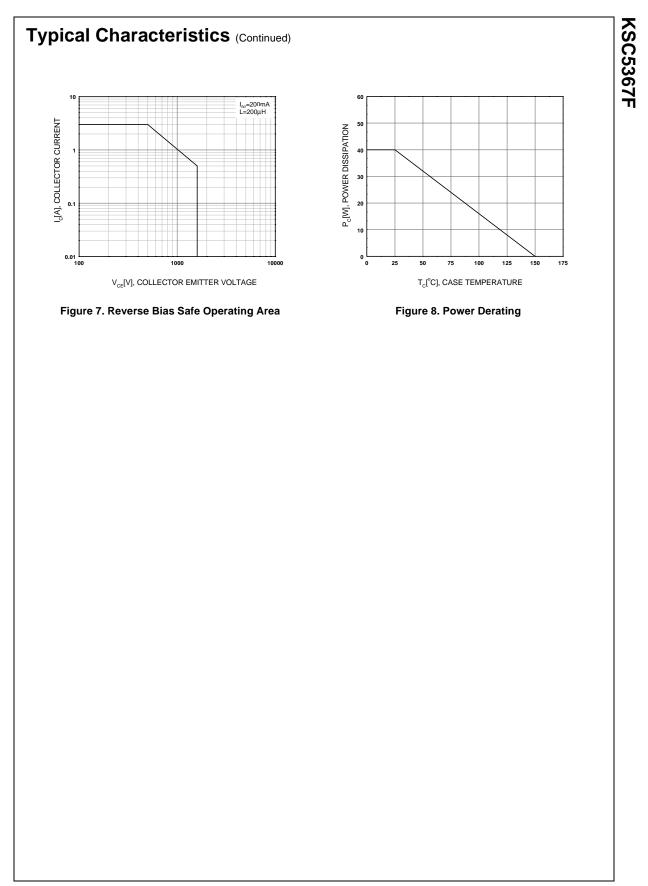
Symbol	Parameter	Test Condition	Min.	Тур.	Max.	Units
ΒV <sub>CBO</sub>	Collector-Base Breakdown Voltage	$I_{\rm C} = 0.5 {\rm mA}, I_{\rm E} = 0$	1600	-	-	V
BV <sub>CEO</sub>	Collector-Emitter Breakdown Voltage	$I_{\rm C} = 5 {\rm mA}, I_{\rm B} = 0$	800	-	-	V
BV <sub>EBO</sub>	Emitter-Base Breakdown Voltage	$I_{\rm C}$ =0.5mA, $I_{\rm C}$ = 0	12	-	-	V
I <sub>CBO</sub>	Collector Cut-off Current	V <sub>CB</sub> = 1,600V, I <sub>E</sub> = 0	-	-	20	μΑ
I <sub>EBO</sub>	Emitter Cut-off Current	$V_{EB} = 12V, I_{C} = 0$	-	-	20	μΑ
h <sub>FE1</sub> h <sub>FE2</sub>	DC Current Gain	$V_{CE} = 3V, I_{C} = 0.4A$ $V_{CE} = 10V, I_{C} = 5mA$	12 8	-	35 -	
V <sub>CE</sub> (sat)	Collector-Emitter Saturation Voltage	$I_{C} = 250$ mA, $I_{B} = 25$ mA $I_{C} = 500$ mA, $I_{B} = 50$ mA $I_{C} = 1$ A, $I_{B} = 0.2$ A	- - -	- -	2.5 4.0 2.5	V V V
V <sub>BE</sub> (sat)	Base-Emitter Saturation Voltage	I <sub>C</sub> = 500mA, I <sub>B</sub> = 50mA	-	-	1.5	V
C <sub>ob</sub>	Output Capacitance	$V_{CB} = 10V, I_E = 0, f = 1MHz$	-	40	-	pF
t <sub>ON</sub>	Turn On Time	$V_{CC} = 125V, I_{C} = 0.5A$	-	-	0.5	μs
t <sub>STG</sub>	Storage Time	$I_{B1} = 42mA, I_{B2} = -333mA$		-	2.2	μs
t <sub>F</sub>	Falling Time	$R_L = 250\Omega$	-	-	0.5	μs
t <sub>ON</sub>	Turn On Time	$V_{CC} = 250V, I_{C} = 1A$	-	-	0.5	μs
t <sub>STG</sub>	Storage Time	I <sub>B1</sub> = 0.2A, I <sub>B2</sub> = -0.4A	-	-	4.0	μs
t <sub>F</sub>	Falling Time	$R_L = 250\Omega$	-	-	0.5	μs

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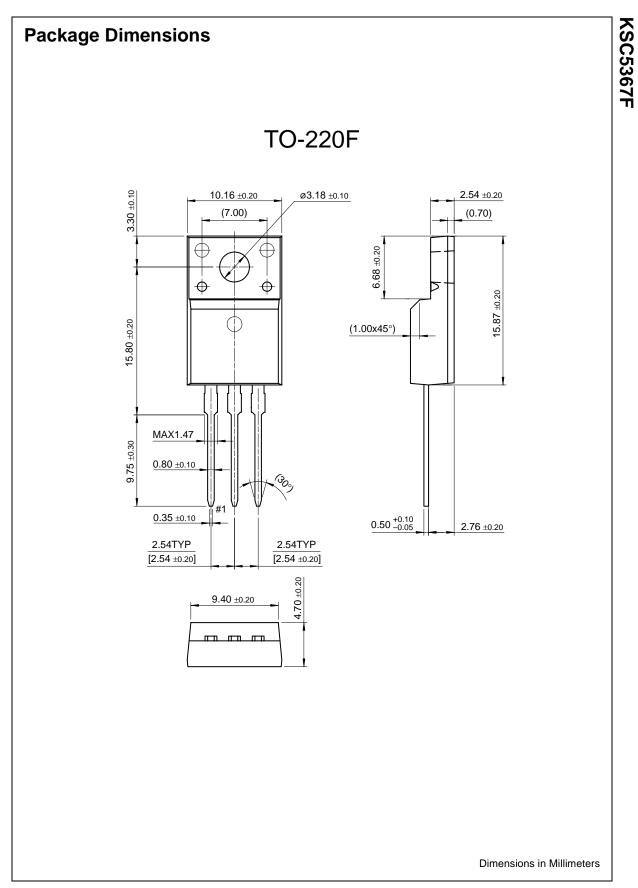


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